

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

NAKAGAWA ET AL.

Examiner

LEILA MALEK

Art Unit

2611

Page 1 of 1

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*	B US-2003/0185309	10-2003	Pautler et al.	375/257
*	C US-2003/0053571	03-2003	Belotserkovsky et al.	375/350
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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